

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/631,842	<b>Applicant(s)/Patent under Reexamination</b> HSIEH, CHIA-TA
	<b>Examiner</b> Dao H. Nguyen	<b>Art Unit</b> 2818

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner